

**Notice of References Cited**

Application/Control No.

10/579,194

Applicant(s)/Patent Under  
Reexamination  
LEE ET AL.

Examiner

Krishnan S. Menon

Art Unit

1797

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,328,886	12-2001	Miyashita et al.	210/220
*	B	US-2002/0139748	10-2002	Cote et al.	210/636
	C	US-			
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	F	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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	S					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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